4194304-BIT (524288-WORD BY 8-BIT) CMOS STATIC RAM

DESCRIPTION

The M5M5408B is a family of 4-Mbit static RAMs organized as 524,288-words by 8-bit, fabricated by Mitsubishi's high-performance 0.25µm CMOS technology.

The M5M5408B is suitable for memory applications where a simple interfacing, battery operating and battery backup are the important design objectives.

M5M5408B is packaged in 32-pin plastic SOP and 32-pin plastic TSOP packages. Two types of TSOPs are available, M5M5408BTP (normal-lead-bend TSOP) and M5M5408BRT (reverse-lead-bend TSOP). These two types TSOPs are suitable for a surface mounting on double-sided printed circuit boards.

From the point of operating temperature, the family is divided into three versions; "Standard", "W-version", and "I-version". Those are summarized in the part name table below.

FEATURES

- Single +5V power supply
- Small stand-by current: 0.4µA(3V,typ.)
- No clocks, No refresh
- Data retention supply voltage=2.0V to 5.5V
- All inputs and outputs are TTL compatible.
- Easy memory expansion by \overline{S}
- · Common Data I/O
- Three-state outputs: OR-tie capability
- OE prevents data contention in the I/O bus
- Process technology: 0.25µm CMOS
- · Package:

M5M5408BFP: 32 pin 525 mil SOP M5M5408BTP/RT: 32 pin 400 mil TSOP(II)

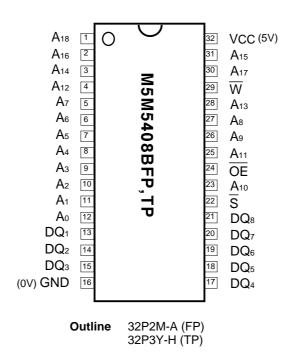
PART NAME TABLE

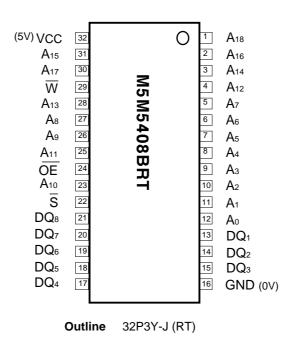
Version, Operating	Part name (## stands for	Power Supply	Access time	Stand-by cu	urrent Icc(PD) Ratings	, Vcc=3.0V s (max.)	Active current Icc1
temperature	"FP","TP","RT")	Сарріу	max.	25°C	70°C	85°C	(5.0V, typ.)
	M5M5408B## -55L	5.0V	55ns		50 A		
Standard	M5M5408B## -70L	5.00	70ns		50µA		
0 ~ +70°C	M5M5408B## -55H	5.01/	55ns				
	M5M5408B## -70H	5.0V	70ns	0.4μA	15μΑ		
	M5M5408B## -55LW	5.0)/	55ns			400.4	50mA
W-version	M5M5408B## -70LW	5.0V	70ns			100μΑ	(10MHz)
-20 ~ +85°C	M5M5408B## -55HW	5.0V	55ns	0.44		204	25mA (1MHz)
	M5M5408B## -70HW	5.00	70ns	0.4μΑ		30µA	
	M5M5408B## -55LI	5.0V	55ns				
I-version -40 ~ +85°C	M5M5408B## -70LI	5.00	70ns			100μΑ	
	M5M5408B## -55HI	5 OV	55ns	0.411		204	
	M5M5408B## -70HI	5.0V	70ns	0.4μΑ		30µA	

^{* &}quot;typical" parameter is sampled, not 100% tested.

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PIN CONFIGURATION (TOP VIEW)





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FUNCTION

The M5M5408BFP,TP,RT is organized as 524,288-words by 8-bit. These devices operate on a single +5.0V power supply, and are directly TTL compatible to both input and output. Its fully static circuit needs no clocks and no refresh, and makes it useful.

A write operation is executed during the \overline{S} low and \overline{W} low overlap time. The address(A0~A18) must be set up before the write cycle

A read operation is executed by setting \overline{W} at a high level and \overline{OE} at a low level while S are in an active state(\overline{S} =L).

When setting \overline{S} at a high level, the chips are in a non-selectable mode in which both reading and writing are disabled. In this mode, the output stage is in a high-impedance state, allowing OR-tie with other chips. Setting the OE at a high level, the output stage is in a high-impedance state, and the data bus contention problem in the write cycle is eliminated.

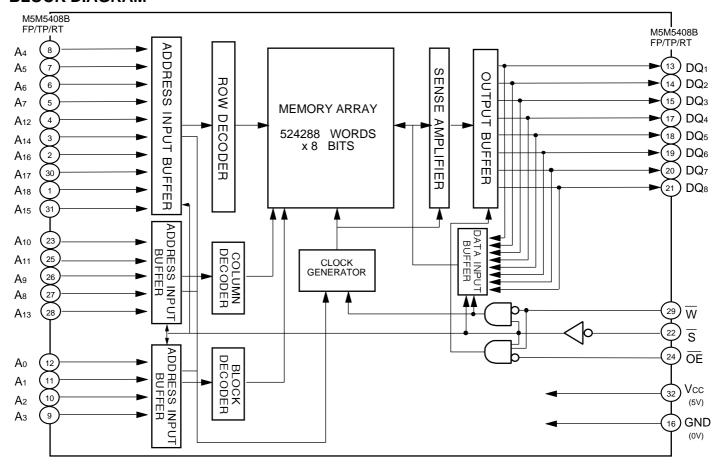
The power supply current is reduced as low as $0.4\mu A(25^{\circ}C,$ typical), and the memory data can be held at +2V power supply, enabling battery back-up operation during power failure or power-down operation in the non-selected mode.

FUNCTION TABLE

s	\overline{W}	ŌE	Mode	DQ	lcc
Н	Х	Х	Non selection	High-impedance	Standby
L	L	Х	Write	Data input (D)	Active
L	Н	L	Read	Data output (Q)	Active
L	Н	Н	Read	High-impedance	Active

Pin	Function
A0 ~ A18	Address input
DQ1 ~ DQ8	Data input / output
S	Chip select input
\overline{W}	Write control input
ŌĒ	Output inable input
Vcc	Power supply
GND	Ground supply

BLOCK DIAGRAM



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ABSOLUTE MAXIMUM RATINGS

Symbol	Parameter	Conditions	Ratings	Units
Vcc	Supply voltage	With respect to GND	-0.3* ~ +7	
Vı	Input voltage	With respect to GND	-0.3* ~ Vcc + 0.3	V
Vo	Output voltage	With respect to GND	0 ~ Vcc	
Pd	Power dissipation	Ta=25°C	700	mW
	Operation	Standard (-L, -H)	0 ~ +70	
Ta	Operating temperature	W-version (-LW, -HW)	-20 ~ +85	°C
		I-version (-LI, -HI)	-40 ~ +85	
Tstg	Storage temperature		-65 ~150	°C

^{* -3.0}V in case of AC (Pulse width 30ns)

DC ELECTRICAL CHARACTERISTICS

(Vcc=5V±10%, unless otherwise noted)

Symbol	Davamatar	Conditions		Limits			l laita
Symbol	Parameter	Conditions		Min	Тур	Max	Units
VIH	High-level input voltage			2.2		Vcc+0.3V	
VIL	Low-level input voltage			-0.3 *		0.8	
V _{OH1}	High-level output voltage 1	Iон= -1mA		2.4			V
V_{OH2}	High-level output voltage 2	Iон= -0.1mA		Vcc-0.5V			
Vol	Low-level output voltage	IoL=2mA				0.4	
lı	Input leakage current	Vı=0 ~ Vcc				±1	μA
lo	Output leakage current	S=Vih or OE=Vih, Vi/o=0 ~ Vcc				±1	μΛ
lcc1	Active supply current	S 0.2V Output-open	f= 10MHz	-	50	80	
1001	(AC,MOS level)	Other inputs 0.2V or Vcc-0.2V	f= 1MHz	-	25	30	mA
10	Active supply current	S=VIL Output-open	f= 10MHz	-	60	90	ША
lcc2	(AC,TTL level)	Other inputs=VIH or VIL	f= 1MHz	-	30	40	
			-LW, -LI	-	-	200	
Icc3	Stand by supply current	S Vcc-0.2V	-L	-	-	100	
	(AC,MOS level)	Other inputs=0~Vcc	-HW, -HI	-	1.0	60	μΑ
			-H	-	1.0	30	
lcc4	Stand by supply current (AC,TTL level)	S=V ,Other inputs= 0 ~ Vcc		-	-	3	mA

Note 1: Direction for current flowing into IC is indicated as positive (no mark)

CAPACITANCE

(Vcc=5.0V±10%, unless otherwise noted)

Symbol	Parameter	Conditions	Limits			l laita
Symbol		Conditions	Min	Тур	Max	Units
Сі	Input capacitance	V=GND, V=25mVrms, f=1MHz			8	
Со	Output capacitance	Vo=GND,Vo=25mVrms, f=1MHz			10	pF

^{* -3.0}V in case of AC (Pulse width 50ns)

Note 2: Typical value is for Vcc=5.0V and Ta=25°C

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AC ELECTRICAL CHARACTERISTICS (Vcc=5.0V±10%, unless otherwise noted)

(1) TEST CONDITIONS

Supply voltage	5.0V
Input pulse	VIH=2.4V,VIL=0.6V (FP,TP,RT-70) VIH=3.0V,VIL=0V (FP,TP,RT-55)
Input rise time and fall time	5ns
Reference level	VOH=VOL=1.5V Transition is measured ±500mV from
	steady state voltage.(for ten,tdis)
Output loads	Fig.1, CL=100pF (FP,TP,RT-70) CL=30pF (FP,TP,RT-55) CL=5pF (for ten,tdis)

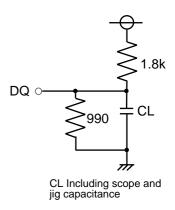


Fig.1 Output load

(2) READ CYCLE

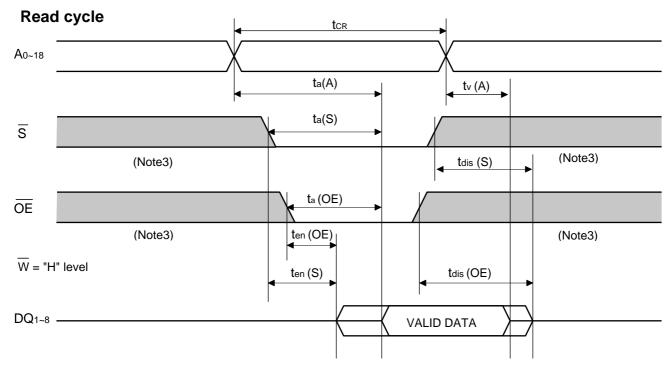
		Limits					
Symbol	Parameter	M5M5408BF	P,TP,RT-55	M5M5408B	Units		
		Min	Max	Min	Max		
t cr	Read cycle time	55		70		ns	
ta(A)	Address access time		55		70	ns	
ta(S)	Chip select access time		55		70	ns	
ta(OE)	Output enable access time		25		35	ns	
tdis(S)	Output disable time after \$\overline{S}\$ high		20		25	ns	
t _{dis} (OE)	Output disable time after OE high		20		25	ns	
ten(S)	Output enable time after \overline{S} low	10		10		ns	
ten(OE)	Output enable time after OE low	5		5		ns	
t∨(A)	Data valid time after address	10		10		ns	

(3) WRITE CYCLE

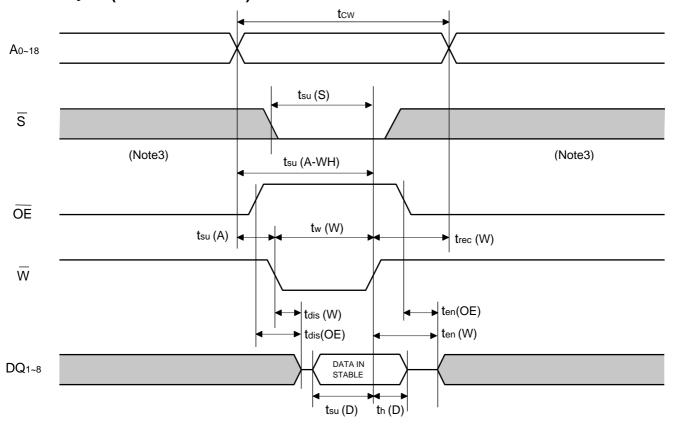
Symbol	Parameter	M5M5408E	BFP,TP,RT-55	M5M5408E	Units	
		Min	Max	Min	Max	
tcw	Write cycle time	55		70		ns
tw(W)	Write pulse width	40		50		ns
tsu(A)	Address set up time	0		0		ns
tsu(A-WH)	Address set up time with respect to \overline{W} high	50		60		ns
tsu(S)	Chip select set up time	50		60		ns
tsu(D)	Data set up time	25		30		ns
th(D)	Data hold time	0		0		ns
trec(W)	Write recovery time	0		0		ns
t _{dis} (W)	Output disable time after $\overline{\overline{W}}$ low		20		25	ns
tdis(OE)	Output disable time after OE high		20		25	ns
t _{en} (W)	Output enable time after W high	5		5		ns
ten(OE)	Output enable time after OE low	5		5		ns

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(4)TIMING DIAGRAMS

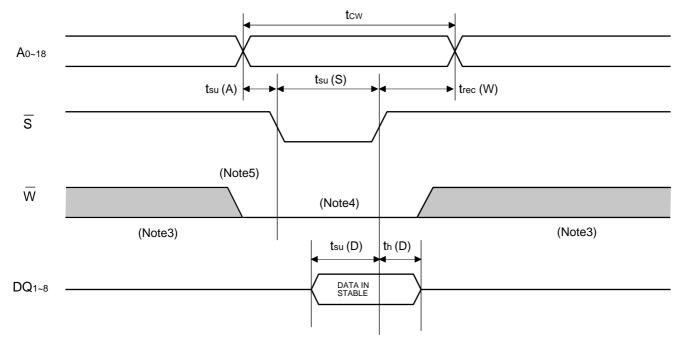


Write cycle (W control mode)



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Write cycle (S control mode)



- Note 3: Hatching indicates the state is "don't care".
- Note 4: A Write occurs during the overlap of a low \overline{S} and a low \overline{W} .
- Note 5: If \overline{W} goes low simultaneously with or prior to \overline{S} , the output remains in the high impedance state.
- Note 6: Don't apply inverted phase signal externally when DQ pin is in output mode.

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POWER DOWN CHARACTERISTICS

(1) ELECTRICAL CHARACTERISTICS

Symbol Parameter		Test conditions		Limits			Units
				Min	Тур.	Max	Units
Vcc (PD)	Power down supply voltage			2	-	•	V
VI (S)	Chip select input \bar{S}	Vcc(PD) 2.2V		2.2	-	-	V
		2.2V Vcc(PD) 2.0V		-	Vcc(PD)	-	V
			-LW, -LI	-	-	100	μA
ICC (PD)	Power down	Vcc=3.0V, S Vcc-0.2V, Other inputs=0 ~ Vcc	-L	ı	-	50	μΑ
	supply current		-HW, -HI	-	0.4	30	μA
			-H	-	0.4	15	μΑ

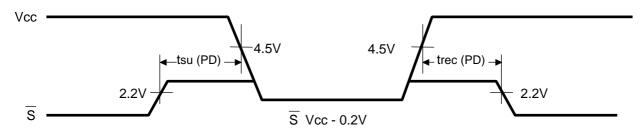
Typical value is for Ta=25°C

(2) TIMING REQUIREMINTS

Symbol	Parameter	T . 197	Limits			l laita
		Test conditions	Min	Тур	Max	Units
tsu (PD)	Power down set up time		0			ns
trec (PD)	Power down recovery time		5			ms

(3) TIMING DIAGRAM

S control mode



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Revision History			
Revision No.	<u>History</u>	<u>Date</u>	
K0.1e	The first edition	'98.7.30	Preliminary
K0.2e	1) lcc3 limit revised	'99.6.3	Preliminary
	2) Icc(PD) limit revised	'98.6.3	Preliminary
	3) lcc1,lcc2 conditions revised	'98.6.3	Preliminary
K0.3e	1) Vcc Level in the Block Diagram revised	'99.6.28	Preliminary
	2) lcc3 limit (typ) revised	'99.6.28	Preliminary
K1.0e	The first product version	'99.10.12	
K1.1e	Product Lineup Revised	'99.10.21	

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